

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10526162	MATSUDA ET AL.
Examiner	Art Unit	
HENOK G HEYI	2627	

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
Searched EAST, specifically 369/275.1, 275.2, 275.3 and 275.4 (text search only - please see search history printout).	8/13/2008	HH
Search updated.	03/23/2009	HH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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Examiner.Alt Unit 2627